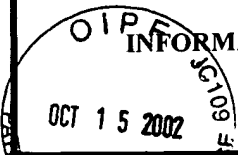


<div style="text-align: center;">  <p>INFORMATION DISCLOSURE CITATION (Use several sheets if necessary)</p> </div>	Docket Number (Optional) TSL1469CIP	Application Number 09/846,834
	Applicant(s) Akamatsu et al.	
	Filing Date 05/01/2001	Group Art Unit

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
SLC		09/915,845		Kobayashi et al.			07/26/2001
SLC		09/915,844		Kobayashi et al.			07/26/2001
SLC		09/994,503		Kobayashi et al.			11/27/2001

FOREIGN PATENT DOCUMENTS

REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						YES	NO
SLC	JP11182624	1999.07.06	Japan (abstract)	F16F	015/04		
	JP2000-08277	2000.3.21	Japan	C08L	83/04		
	JP62-113932	1987.5.25	Japan (abstract)	F16F	013/00		
	JP63-308241	1988.12.15	Japan (abstract)	F16F	013/00		
SLC	JP63-308242	1988.12.15	Japan (abstract)	F16F	013/00		

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INFORMATION DISCLOSURE CITATION

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Docket Number (Optional)

TSL1469CI

Application Number

09/846,834

Applicant(s)

Akamatsu et al.

Filing Date

05/01/2001

Group Art Unit

1743

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*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
SIC		4,374,950	02/22/1983	Shimizu	524	765	
		4,416,790	11/22/1983	Schurmann et al.	252	62	
		4,514,529	04/30/1985	Beers et al.	523	200	
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							YES	NO
SIC		EP 0 635 549 B1	05.07.1994	European	C08L	83/04		
		EP 0 990 816 A1	29.09.1999	European	F16F	9/00		
		JP09263525	1997.10.07	Japan (abstract)	A61K	007/46		
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SIC		JP10281202	1998.10.23	Japan (abstract)	F16F	009/30		

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER

CROSS, L.

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